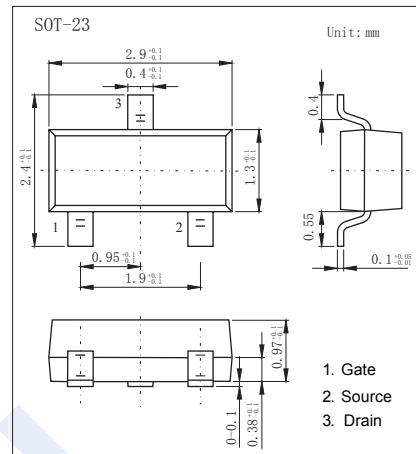


N-Channel MOSFET

FDV301N

■ Features

- 0.22 A, 25 V. $R_{DS(ON)} = 4 \Omega$ @ $V_{GS} = 4.5$ V
 $R_{DS(ON)} = 5\Omega$ @ $V_{GS} = 2.7$ V.
- Very low level gate drive requirements allowing direct operation in 3V circuits. $V_{GS(th)} < 1.5$ V.
- Gate-Source Zener for ESD ruggedness.
>6kV Human Body Model
- Replace multiple NPN digital transistors with one DMOSFET.



■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	Rating	Unit
Drain-Source Voltage, Power Supply Voltage	V _{DSS} , V _{CC}	25	V
Gate-Source Voltage, V _{IN}	V _{GSS} , V _I	8	V
Drain/Output Current - Continuous - pulse	I _D	0.22 0.5	A
Maximum Power Dissipation	P _D	0.35	W
Electrostatic Discharge Rating MIL-STD-883D Human Body Model (100pf / 1500 Ohm)	ESD	6	kV
Thermal Resistance, Junction-to- Ambient	R _{θJA}	357	°C/W
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-55 to +150	°C

■ Inverter Electrical Characteristics TA = 25°C unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Zero Input Voltage Output Current	I _O (off)	V _{CC} = 20 V, V _I = 0 V			1.0	μA
Input Voltage	V _I (off)	V _{CC} = 5 V, I _O = 10 μA			0.5	V
	V _I (on)	V _O = 0.3 V, I _O = 5 mA	1.0			V
Output to Ground Resistance	R _O (on)	V _I = 2.7 V, I _O = 0.2 A			5.0	Ω

N-Channel MOSFET

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■ Electrical Characteristics $T_a = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V_{DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V
Breakdown Voltage Temp. Coefficient	$\Delta V_{DSS}/\Delta T_J$	$I_D = 250 \mu\text{A}$, Referenced to 25°C		25		$\text{mV}/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$			10	μA
Gate-Body Leakage Current,Forward	I_{GSSF}	$V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
Gate-Body Leakage Current,Reverse	I_{GSSR}	$V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
Gate Threshold Voltage (Note)	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	0.65	0.8	1.5	V
Gate Threshold Voltage Temp. Coefficient (Note)	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu\text{A}$, Referenced to 25°C		-2.1		$\text{mV}/^\circ\text{C}$
Static Drain-Source On-Resistance(Note)	$R_{DS(on)}$	$V_{GS} = 4.5 \text{ V}, I_D = 0.4 \text{ A}$			4.0	Ω
		$V_{GS} = 2.7 \text{ V}, I_D = 0.2 \text{ A}$			5.0	
On-State Drain Current (Note)	$I_{D(on)}$	$V_{GS} = 2.7 \text{ V}, V_{DS} = 5 \text{ V}$	0.2			A
Forward Transconductance	g_{FS}	$V_{DS} = 5 \text{ V}, I_D = 0.4 \text{ A}$		0.2		S
Input Capacitance	C_{iss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$		9.5		pF
Output Capacitance	C_{oss}			6.0		
Reverse Transfer Capacitance	C_{rss}			1.3		
Turn-On Delay Time (Note)	$t_{d(on)}$	$V_{DD} = 6 \text{ V}, I_D = 0.5 \text{ A}, V_{GS} = 4.5 \text{ V}, R_{GEN} = 50 \Omega$		3.2	8	ns
Turn-On Rise Time (Note)	t_r			6	15	
Turn-Off Delay Time (Note)	$t_{d(off)}$			3.5	8	
Turn-Off Fall Time (Note)	t_f			3.5	8	
Total Gate Charge (Note)	Q_g	$V_{DS} = 5 \text{ V}, I_D = 0.2 \text{ A}, V_{GS} = 4.5 \text{ V}$		0.49	0.7	nC
Gate-Source Charge (Note)	Q_{gs}			0.22		
Gate-Drain Charge (Note)	Q_{gd}			0.07		
Maximum Continuous Drain-Source Diode Forward Current	I_S				0.29	A
Drain-Source Diode ForwardVoltage(Note)	V_{SD}	$V_{GS} = 0 \text{ V}, I_S = 0.29 \text{ A}$			1.2	V

Note: Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

■ Marking

Marking	301
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N-Channel MOSFET

FDV301N

■ Typical Characteristics

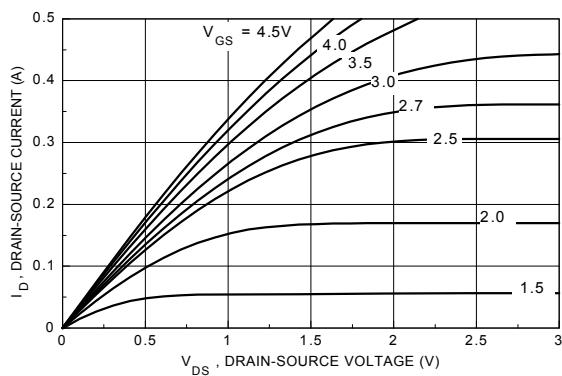


Figure 1. On-Region Characteristics.

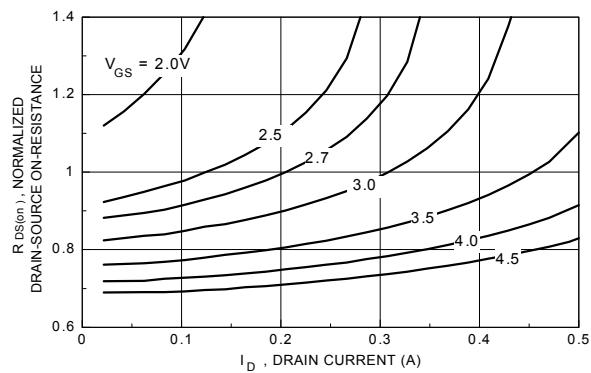


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

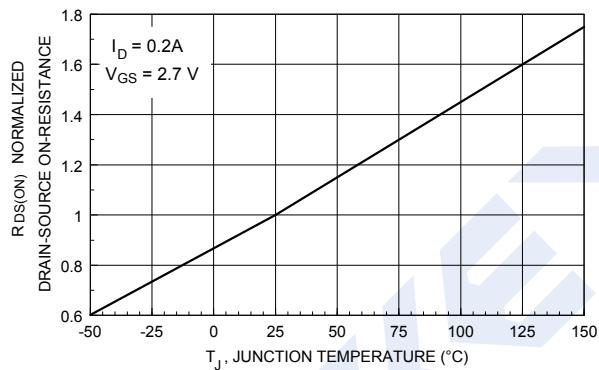


Figure 3. On-Resistance Variation with Temperature.

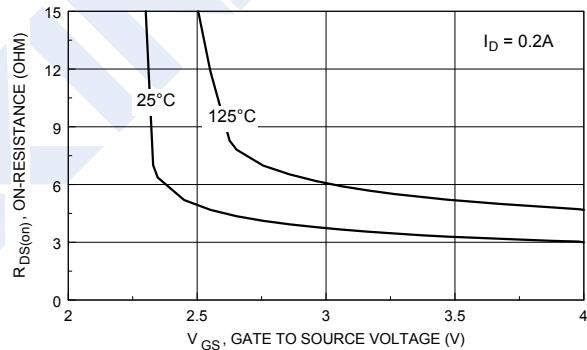


Figure 4. On Resistance Variation with Gate-To-Source Voltage.

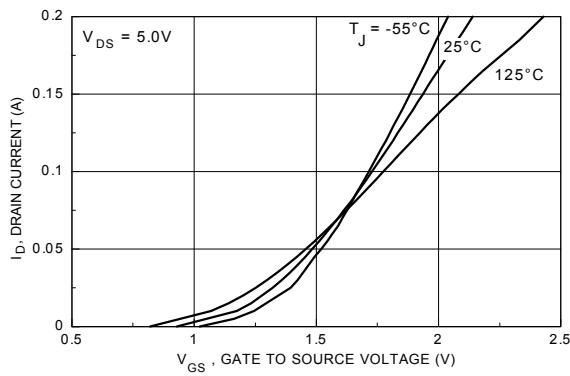


Figure 5. Transfer Characteristics.

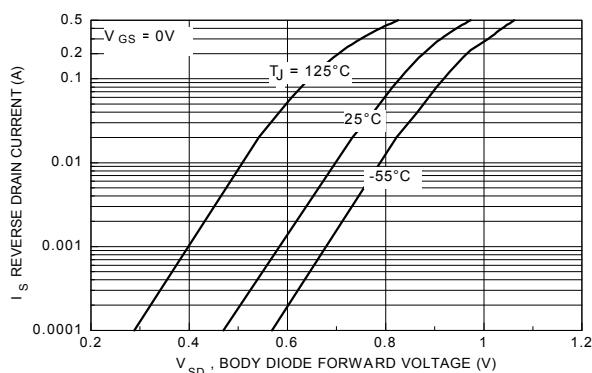


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

N-Channel MOSFET

FDV301N

■ Typical Characteristics

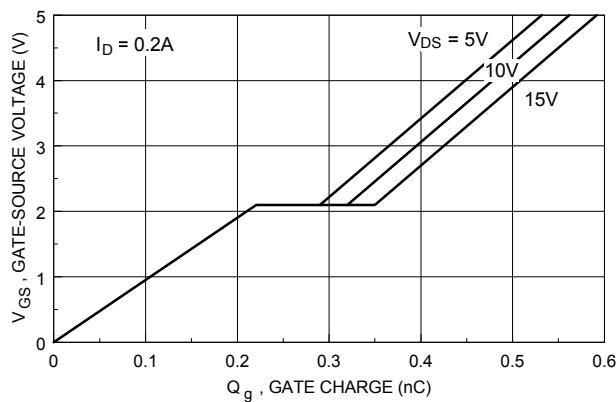


Figure 7. Gate Charge Characteristics.

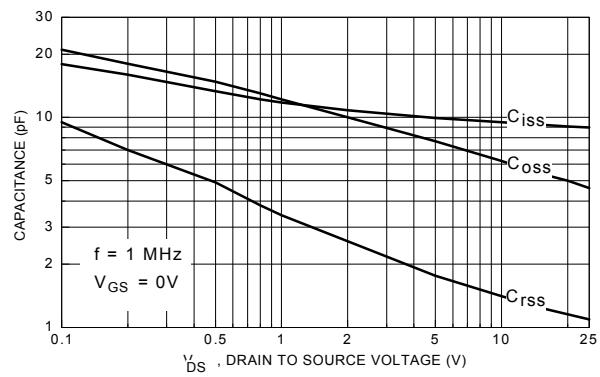


Figure 8. Capacitance Characteristics.

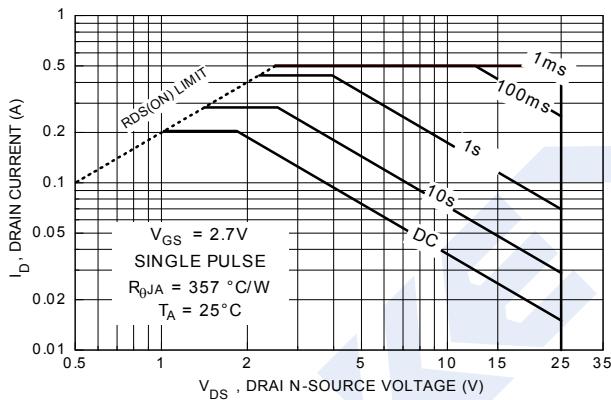


Figure 9. Maximum Safe Operating Area.

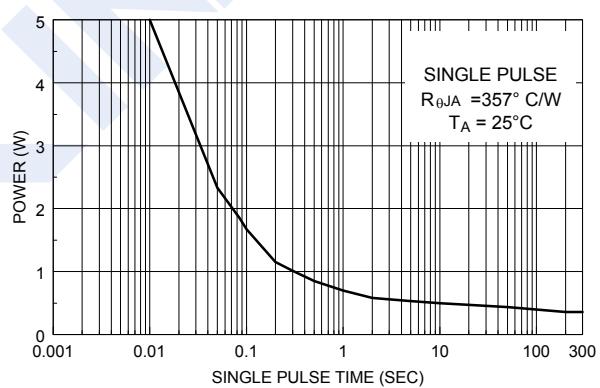


Figure 10 . Single Pulse Maximum Power Dissipation.

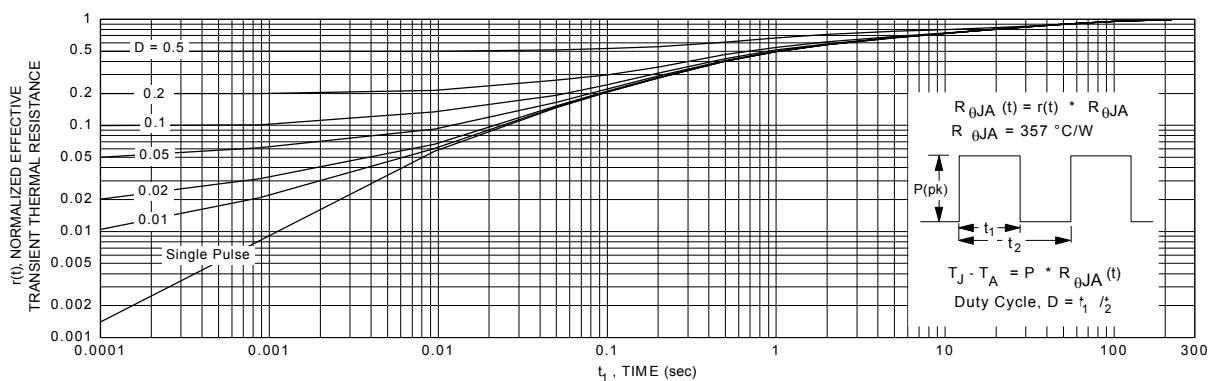


Figure 11 . Transient Thermal Response Curve .